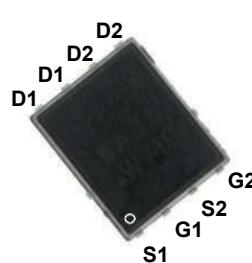
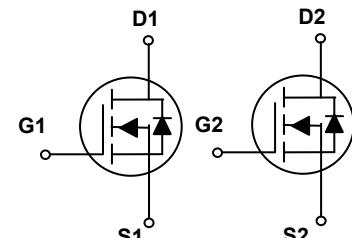


### Main Product Characteristics

$V_{(BR)DSS}$	100V
$R_{DS(ON)}$	27mΩ (Max)
$I_D$	32A



PPAK5x6



Schematic Diagram

### Features and Benefits

- Advanced MOSFET process technology
- Ideal for high efficiency switched mode power supplies
- Low on-resistance with low gate charge
- Fast switching and reverse body recovery



### Description

The GSFP27010 utilizes the latest techniques to achieve high cell density and low on-resistance. These features make this device extremely efficient and reliable for use in high efficiency switch mode power supplies and a wide variety of other applications.

### Absolute Maximum Ratings ( $T_J=25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Parameter	Unit
Drain-Source Voltage	$V_{DS}$	100	V
Gate-to-Source Voltage	$V_{GS}$	$\pm 20$	V
Continuous Drain Current, @ Steady-State ( $T_c=25^\circ\text{C}$ ) <sup>1</sup>	$I_D$	32	A
Continuous Drain Current, @ Steady-State ( $T_c=100^\circ\text{C}$ ) <sup>1</sup>		23	A
Pulsed Drain Current ( $T_c=25^\circ\text{C}$ ) <sup>2</sup>	$I_{DM}$	128	A
Power Dissipation ( $T_c=25^\circ\text{C}$ ) <sup>3</sup>	$P_D$	69	W
Single Pulse Avalanche Energy	$E_{AS}$	9.8	mJ
Single Pulse Avalanche Current	$I_{AS}$	14	A
Junction-to-Ambient (PCB Mounted, Steady-State)	$R_{\theta JA}$	62	°C/W
Junction-to-Case	$R_{\theta JC}$	1.81	°C/W
Operating Junction and Storage Temperature Range	$T_J/T_{STG}$	-55 to +150	°C
Soldering Temperature (SMD)	$T_{sold}$	260	°C

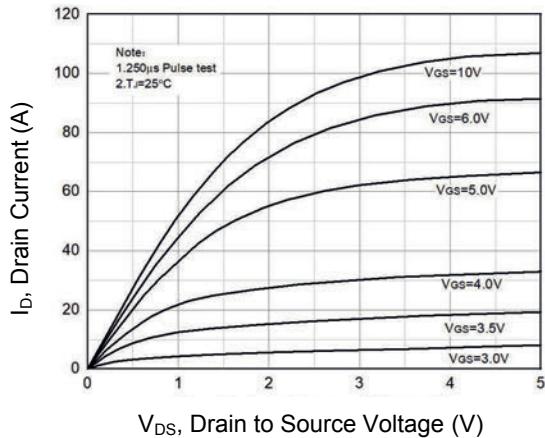
**Electrical Characteristics** ( $T_J=25^\circ\text{C}$  unless otherwise specified)

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
<b>On / Off Characteristics</b>						
Drain-to-Source Breakdown Voltage	$V_{(\text{BR})\text{DSS}}$	$V_{\text{GS}}=0\text{V}, I_D=250\mu\text{A}$	100	-	-	V
Drain-to-Source Leakage Current	$I_{\text{DSS}}$	$V_{\text{DS}}=100\text{V}, V_{\text{GS}}=0\text{V}, T_J=25^\circ\text{C}$	-	-	1.0	$\mu\text{A}$
		$V_{\text{DS}}=100\text{V}, V_{\text{GS}}=0\text{V}, T_J=125^\circ\text{C}$	-	1.2	-	
Gate-to-Source Forward Leakage	$I_{\text{GSS}}$	$V_{\text{DS}}=0\text{V}, V_{\text{GS}}=20\text{V}$	-	-	100	$\text{nA}$
		$V_{\text{DS}}=0\text{V}, V_{\text{GS}}=-20\text{V}$	-	-	-100	
Static Drain-to-Source On-Resistance	$R_{\text{DS}(\text{ON})}$	$V_{\text{GS}}=10\text{V}, I_D=6\text{A}$	-	20	27	$\text{m}\Omega$
		$V_{\text{GS}}=10\text{V}, I_D=5\text{A}$	-	24	29	
Gate Threshold Voltage	$V_{\text{GS}(\text{th})}$	$V_{\text{DS}}=V_{\text{GS}}, I_D=250\mu\text{A}$	1.1	-	2.8	V
<b>Dynamic and Switching Characteristics</b>						
Input Capacitance	$C_{\text{iss}}$	$V_{\text{GS}}=0\text{V}, V_{\text{DS}}=50\text{V}, f=1\text{MHz}$	-	1053	-	$\text{pF}$
Output Capacitance	$C_{\text{oss}}$		-	129	-	
Reverse Transfer Capacitance	$C_{\text{rss}}$		-	3.9	-	
Total Gate Charge <sup>4,5</sup>	$Q_g$	$I_D=10\text{A}, V_{\text{DD}}=50\text{V}, V_{\text{GS}}=10\text{V}$	-	15	-	$\text{nC}$
Gate-to-Source Charge <sup>4,5</sup>	$Q_{\text{gs}}$		-	4.2	-	
Gate-to-Drain ("Miller") Charge <sup>4,5</sup>	$Q_{\text{gd}}$		-	3.6	-	
Gate Plateau <sup>4,5</sup>	$V_{\text{plateau}}$		-	3.9	-	V
Turn-on Delay Time <sup>4,5</sup>	$t_{\text{d}(\text{on})}$	$V_{\text{DD}}=50\text{V}, V_{\text{GS}}=10\text{V}, R_{\text{G}}=1.6\Omega, I_D=8\text{A}$	-	6.2	-	$\text{nS}$
Rise Time <sup>4,5</sup>	$t_r$		-	30	-	
Turn-Off Delay Time <sup>4,5</sup>	$t_{\text{d}(\text{off})}$		-	20	-	
Fall Time <sup>4,5</sup>	$t_f$		-	9.3	-	
Gate Resistance	$R_g$	$f=1\text{MHz}$	-	1.8	-	$\Omega$
<b>Source-Drain Ratings and Characteristics</b>						
Continuous Source Current (Body Diode)	$I_s$	MOSFET symbol showing the integral reverse p-n junction diode.	-	-	32	A
Diode Pulse Current	$I_{\text{S, pulse}}$		-	-	128	A
Diode Forward Voltage	$V_{\text{SD}}$	$I_s=8\text{A}, V_{\text{GS}}=0\text{V}$	-	-	1.4	V
Reverse Recovery Time <sup>4</sup>	$T_{\text{rr}}$	$I_s=8\text{A}, V_{\text{GS}}=0\text{V}, V_R=50\text{V}, \text{d}I/\text{dt}=100\text{A/us}$	-	33	-	nS
Reverse Recovery Charge <sup>4</sup>	$Q_{\text{rr}}$		-	36	-	nC

Notes:

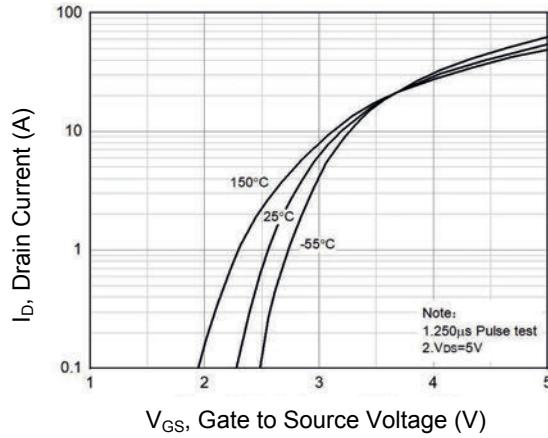
- The rated value only refers to the maximum absolute value under  $25^\circ\text{C}$  shell temperature in the manual.  
If the shell temperature is higher than  $25^\circ\text{C}$ , the rating shall be reduced according to the actual environmental conditions.
- Pulse time  $5\mu\text{s}$ , and the pulse width is limited to the maximum junction temperature.
- The value of dissipated power will change with the temperature. When the temperature is higher than  $25^\circ\text{C}$ , the value of dissipated power will decrease by  $0.04\text{W}/^\circ\text{C}$  with each temperature rise of  $1^\circ\text{C}$ .
- Pulse test: pulse width  $\leq 300\mu\text{s}$ , duty cycle  $\leq 2\%$ .
- Essentially independent of operating temperature.

## Typical Electrical and Thermal Characteristic Curves



$V_{DS}$ , Drain to Source Voltage (V)

Figure 1. Typical Output Characteristics



$V_{GS}$ , Gate to Source Voltage (V)

Figure 2. Transfer Characteristics

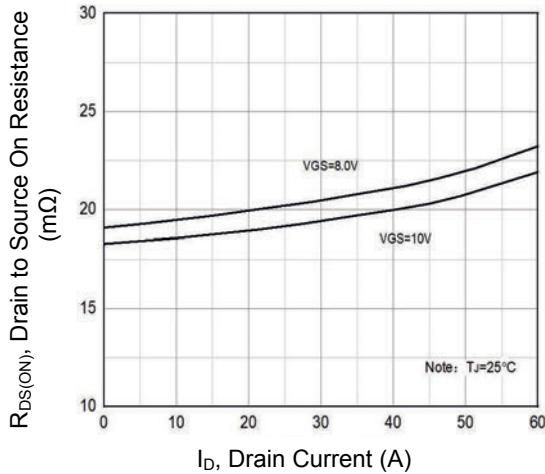


Figure 3.  $R_{DS(ON)}$  vs. Drain Current

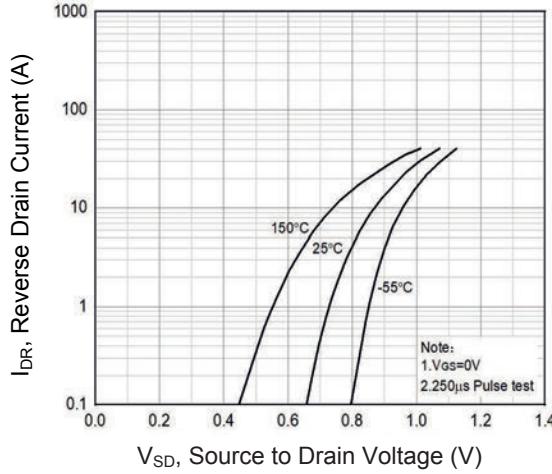
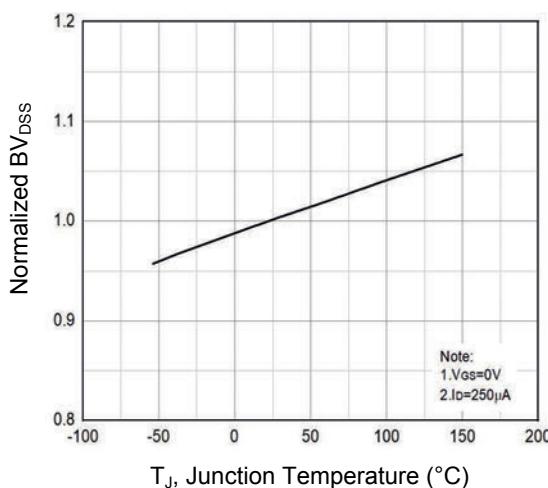


Figure 4. Body Diode Characteristics



$T_J$ , Junction Temperature (°C)

Figure 5. Normalized  $BV_{DSS}$  vs.  $T_J$

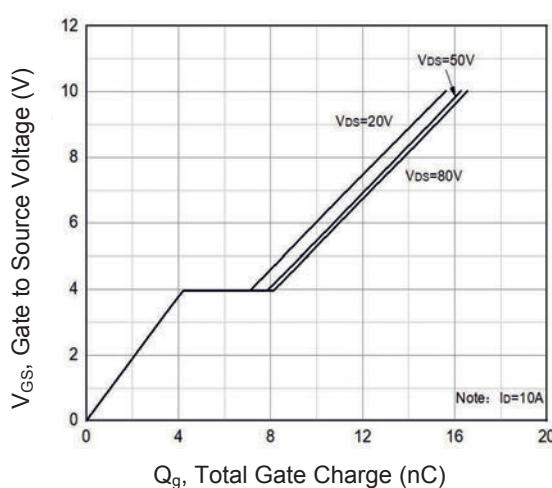


Figure 6. Gate Charge

## Typical Electrical and Thermal Characteristic Curves

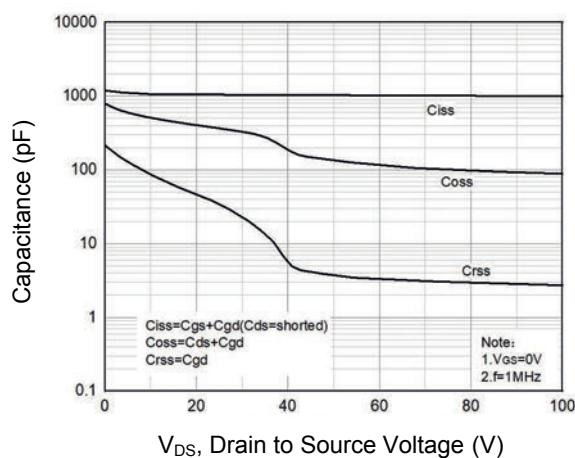


Figure 7. Capacitance Characteristics

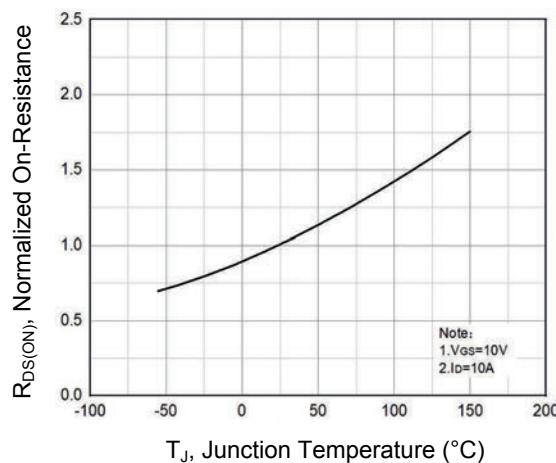


Figure 8. Normalized  $R_{DS(ON)}$  vs.  $T_J$

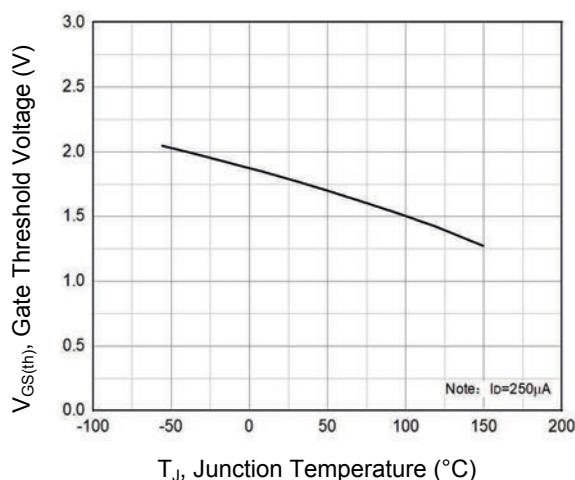


Figure 9. Gate Threshold Voltage vs.  $T_J$

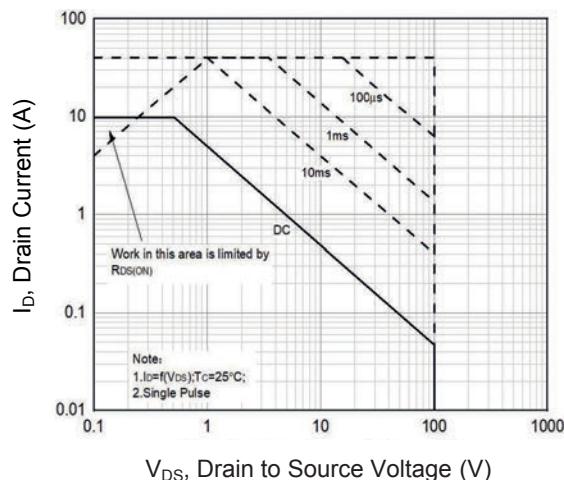
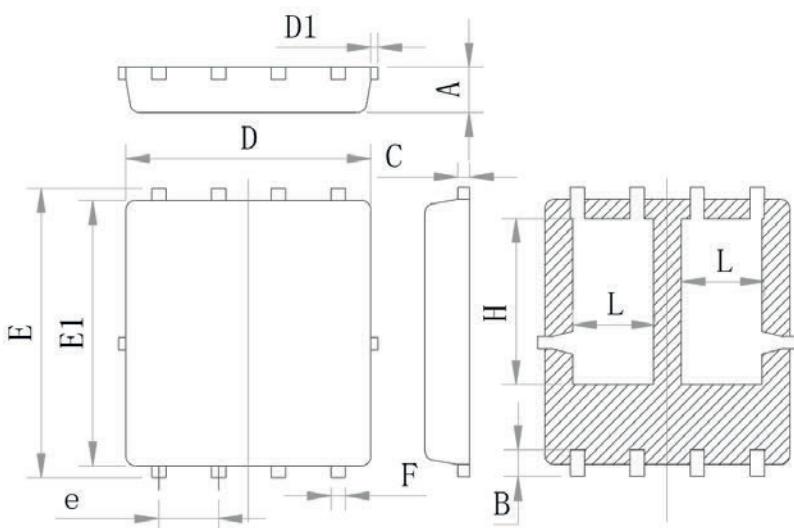


Figure 10. Safe Operation Area

### Package Outline Dimensions (PPAK5x6)



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	0.90	1.00	0.035	0.039
B	0.48	0.68	0.019	0.027
C	0.20	0.30	0.008	0.012
D	5.00	5.40	0.197	0.213
D1	-	0.15	-	0.006
E	5.90	6.20	0.232	0.244
E1	5.60	6.00	0.220	0.236
e	1.22	1.32	0.048	0.052
F	0.25	0.35	0.010	0.014
H	3.27	3.67	0.129	0.144
L	1.50	1.90	0.059	0.075

### Order Information

Device	Package	Marking	Quantity	HSF Status
GSFP27010	PPAK5x6	P27010	5,000pcs / Reel	RoHS Compliant